Supertex inc.

N-Channel Enhancement-Mode Vertical DMOS Power FETs

Ordering Information

BV_{DSS} / BV_{DGS}	$R_{DS(ON)}$ (max)	$I_{D(ON)}$ (min)	Order Number / Package							
			TO-39	TO-92	TO-52	TO-220	Quad P-DIP	Quad C-DIP	Quad C-LCC	DICE
40V	3Ω	2.0A	VN0104N2	VN0104N3	VN0104N9	VN0104N5	VN0104N6	VN0104N7	—	VN0104ND
60V	3Ω	2.0A	VN0106N2	VN0106N3	VN0106N9	VN0106N5	VN0106N6	VN0106N7	VN0106NE	VN0106ND
90V	3Ω	2.0A	VN0109N2	VN0109N3	VN0109N9	VN0109N5	—	—	VN0109NE	VN0109ND

Features

- ☐ Freedom from secondary breakdown
- ☐ Low power drive requirement
- ☐ Ease of paralleling
- ☐ Low C_{ISS} and fast switching speeds
- ☐ Excellent thermal stability
- ☐ Integral Source-Drain diode
- ☐ High input impedance and high gain
- ☐ Complementary N- and P-Channel devices

Advanced DMOS Technology

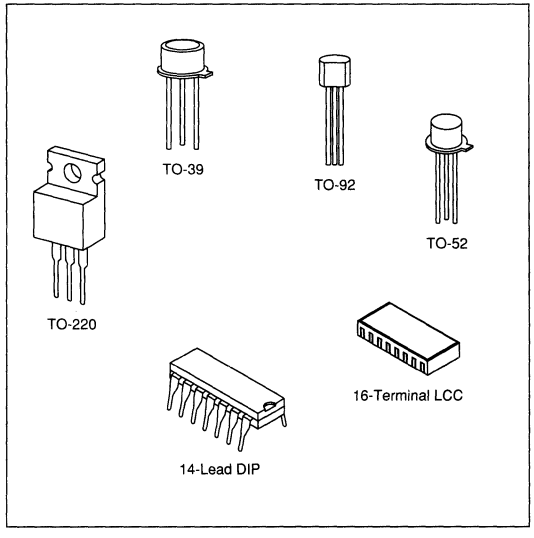
These enhancement-mode (normally-off) power transistors utilize a vertical DMOS structure and Supertex's well-proven silicon-gate manufacturing process. This combination produces devices with the power handling capabilities of bipolar transistors and with the high input impedance and negative temperature coefficient inherent in MOS devices. Characteristic of all MOS structures, these devices are free from thermal runaway and thermally-induced secondary breakdown.

Supertex Vertical DMOS Power FETs are ideally suited to a wide range of switching and amplifying applications where high breakdown voltage, high input impedance, low input capacitance, and fast switching speeds are desired.

Applications

- ☐ Motor control
- ☐ Converters
- ☐ Amplifiers
- ☐ Switches
- ☐ Power supply circuits
- ☐ Drivers (Relays, Hammers, Solenoids, Lamps, Memories, Displays, Bipolar Transistors, etc.)

Package Options



Absolute Maximum Ratings

Drain-to-Source Voltage	BV_{DSS}
Drain-to-Gate Voltage	BV_{DGS}
Gate-to-Source Voltage	± 20V
Operating and Storage Temperature	-55°C to +150°C
Soldering Temperature*	300°C

*Distance of 1.6 mm from case for 10 seconds.

Thermal Characteristics

Package	I_D (continuous)*	I_D (pulsed)*	Power Dissipation @ T_C = 25°C	θ_{ja} °C/W	θ_{jc} °C/W	I_{DR}	I_{DRM}*
TO-39	0.8A	2.5A	3.5W	125	35	0.08A	2.5A
TO-92	0.5A	2.0A	1.0W	170	125	0.5A	2.0A
TO-52	0.5A	2.0A	1.0W	170	125	0.5A	2.0A
TO-220	1.5A	2.5A	15.0W	70	8	1.5A	2.5A
Plastic DIP Ceramic DIP Ceramic LCC	See DMOS Arrays & Special Functions section						

* I_D (continuous) is limited by max rated T_j.

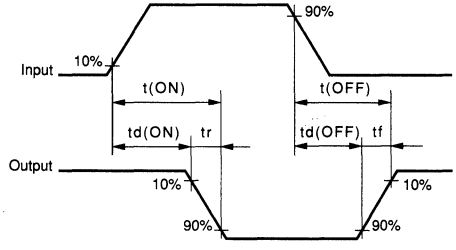
Electrical Characteristics (@ 25°C unless otherwise specified)

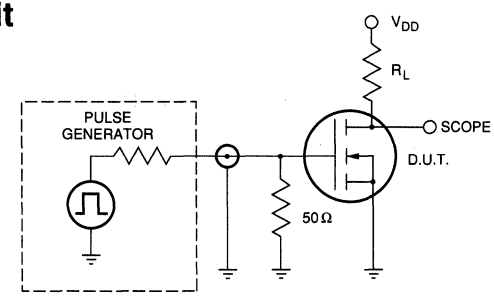
(Notes 1 and 2)

Symbol	Parameter		Min	Typ	Max	Unit	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	VN0109	90			V	V_{GS} = 0, I_D = 1mA
		VN0106	60				
		VN0104	40				
$V_{GS(th)}$	Gate Threshold Voltage		0.8		2.4	V	V_{GS} = V_{DS}, I_D = 1mA
$\Delta V_{GS(th)}$	Change in $V_{GS(th)}$ with Temperature			-3.8	-5.5	mV/°C	V_{GS} = V_{DS}, I_D = 1mA
I_{GSS}	Gate Body Leakage			0.1	100	nA	V_{GS} = ± 20V, V_{DS} = 0
I_{DSS}	Zero Gate Voltage Drain Current				1	µA	V_{GS} = 0, V_{DS} = Max Rating
					100		V_{GS} = 0, V_{DS} = 0.8 Max Rating T_A = 125°C
$I_{D(ON)}$	ON-State Drain Current		0.5	1.0		A	V_{GS} = 5V, V_{DS} = 25V
			2.0	2.50			V_{GS} = 10V, V_{DS} = 25V
$R_{DS(ON)}$	Static Drain-to-Source ON-State Resistance			4.50	5	Ω	V_{GS} = 5V, I_D = 250mA
				2	3		V_{GS} = 10V, I_D = 1A
$\Delta R_{DS(ON)}$	Change in $R_{DS(ON)}$ with Temperature			0.70	1	%/°C	V_{GS} = 10V, I_D = 1A
G_{FS}	Forward Transconductance		300	400		m℧	V_{DS} = 25V, I_D = 0.5A
C_{ISS}	Input Capacitance			45	60	pF	V_{GS} = 0, V_{DS} = 25V f = 1 MHz
C_{OSS}	Common Source Output Capacitance			20	25		
C_{RSS}	Reverse Transfer Capacitance			2	5		
$t_{d(ON)}$	Turn-ON Delay Time			3	5	ns	V_{DD} = 25V I_D = 1A R_S = R_L = 50Ω
t_r	Rise Time			5	8		
$t_{d(OFF)}$	Turn-OFF Delay Time			6	9		
t_f	Fall Time			5	8		
V_{SD}	Diode Forward Voltage Drop			1.2	1.8	V	V_{GS} = 0, I_{SD} = 2.5A
t_{rr}	Reverse Recovery Time			400		ns	V_{GS} = 0, I_{SD} = 1A

Note 1: All D.C. parameters 100% tested at 25°C unless otherwise stated. (Pulse test: 300µs pulse, 2% duty cycle.)
Note 2: All A.C. parameters sample tested.

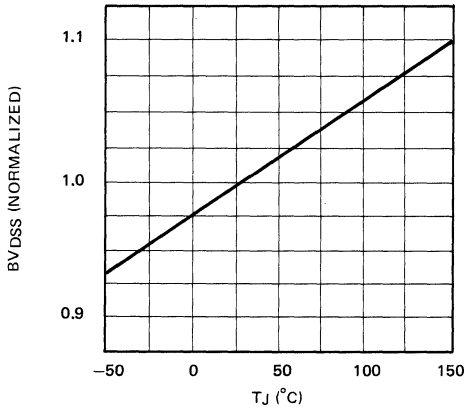
Switching Waveforms and Test Circuit



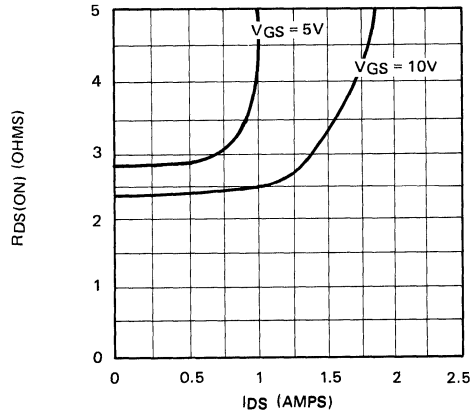


Typical Performance Curves

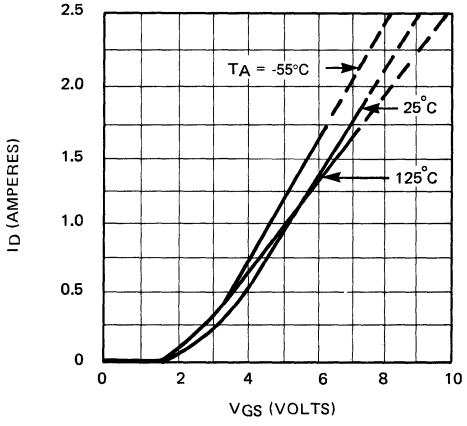
BVDSS Variation with Temperature



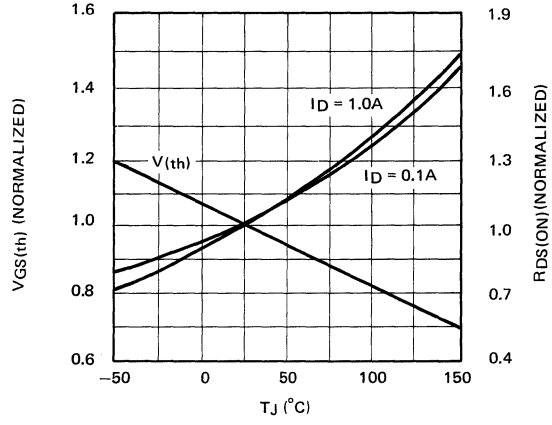
ON – Resistance Vs. Drain Current



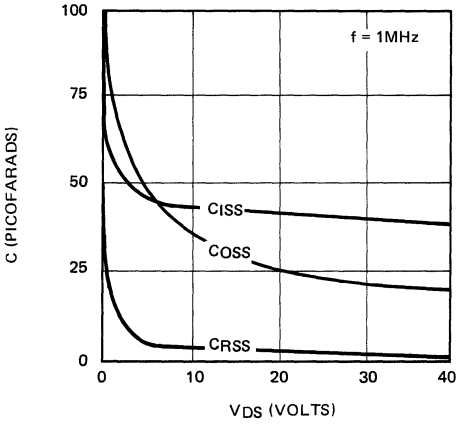
Transfer Characteristics



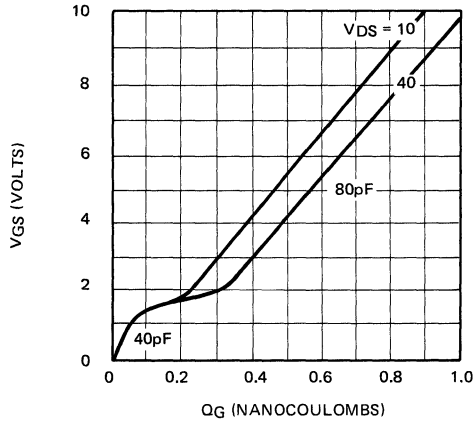
V(th) and RDS Variation with Temperature



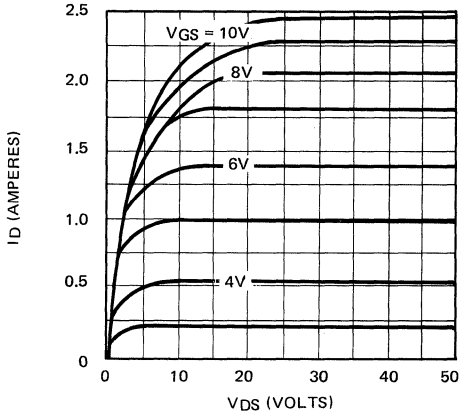
Capacitance Vs. Drain-to-Source Voltage



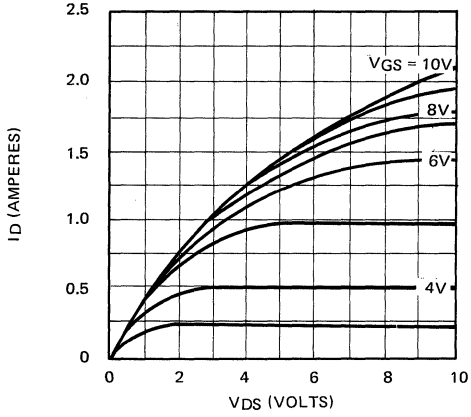
Gate Drive Dynamic Characteristics



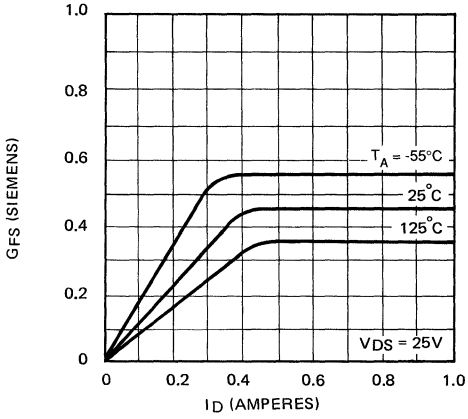
Output Characteristics



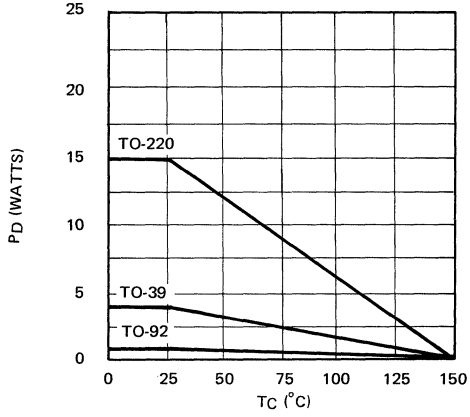
Saturation Characteristics



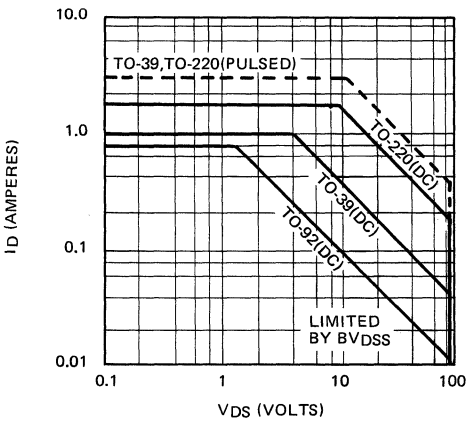
Transconductance Vs. Drain Current



Power Dissipation Vs. Case Temperature



Maximum Rated Safe Operating Area



Thermal Response Characteristics